

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 252008US2		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kazuei YOSHIOKA, et al.			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,251,235	10/05/93	Bengt HENOCH			
	AB	5,012,075	04/30/91	Brian G. HUTCHISON, et al.			
	AC	6,315,279	11/13/01	Hayato MINAMISHIN, et al.			
	AD	4,992,648	02/12/91	Brian G. HUTCHISON			
	AE	5,458,285	10/17/95	Jerome REMIEN			
	AF	4,337,393	06/29/82	Graham H. HILTON			
	AG	2003/0000957 A1	01/02/03	Dirk BREXEL, et al.			
	AH	2001/0054643 A1	12/27/01	John SIEMENS			
	AI						
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AM	6-3632	01/12/94	Japan (with English Abstract)			X
	AN	10-340364	12/22/98	Japan (with English Abstract)			X
	AO	3-3095	01/09/91	Japan (with English Abstract)			X
	AP	60-198678	10/08/85	Japan (with English Abstract)			X
	AQ	2002-319054	10/31/02	Japan (with English Abstract)			X
	AR	2002-319060	10/31/02	Japan (with English Abstract)			X
	AS	2-297695	12/10/90	Japan (with English Abstract)			X
	AT	2553095	08/22/96	Japan (with English Abstract)			X
	AU	60-17584	01/29/85	Japan (with English Abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AV						
	AW						
	AX						
	AY					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Kalyan Kumar/					Date Considered 05/19/2008		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /KK/